

**Search Notes**

Application/Control No.

10/729,138

Examiner

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Applicant(s)/Patent under  
Reexamination

HENDEL ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
711	154-158	4/17/2006	CBS
711	112-118	4/17/2006	CBS
710	6, 39	4/17/2006	CBS
710	117	4/17/2006	CBS
710	52-61	4/17/2006	CBS
710	33-39	4/17/2006	CBS
714	6	4/17/2006	CBS
718	103	4/17/2006	CBS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	6, 33, 58	9/4/2006	CBS
711	158	9/4/2006	CBS
718	102	9/4/2006	CBS

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	4/17/2006	CBS
PALM (Double Patenting)	4/17/2006	CBS
EAST (EPO, JPO, DERWENT, IBMTDB, USPGPUB, USOCR, USPAT)	4/17/2006	CBS